

Fabrication and characterization of superconducting circuit QED devices for quantum computation

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Abstract—We present fabrication and characterization procedures of devices for circuit quantum electrodynamics (cQED). We have made 3 GHz cavities with quality factors in the range $10^4 - 10^6$, which allow access to the strong coupling regime of cQED. The cavities are transmission line resonators made by photolithography. They are coupled to the input and output ports via gap capacitors. An Al-based Cooper pair box is made by e-beam lithography and Dolan bridge double-angle evaporation in superconducting resonators with high quality factor. An important issue is to characterize the quality factor of the resonators. We present an RF-characterization of superconducting resonators as a function of temperature and magnetic field. We have realized different versions of the system with different box-cavity couplings by using different dielectrics and by changing the box geometry. Moreover, the cQED approach can be used as a diagnostic tool of qubit internal losses.

Index Terms—Distributed parameter circuits, Q factor, Scattering parameters measurement, Superconducting cavity resonators.

I. INTRODUCTION

WE have recently demonstrated that a superconducting quantum two-level system can be strongly coupled to a single microwave photon [1]. The strong coupling between a quantum solid state circuit and an individual photon, analogous to atomic cavity quantum electrodynamics (CQED) [2], has previously been envisaged by many authors, see [3] and references therein. Our circuit quantum electrodynamics architecture [3], in which a superconducting charge qubit, the Cooper pair box (CPB) [4], is coupled strongly to a coplanar transmission line resonator, has great prospects both for performing quantum optics experiments [5] in solids and for realizing elements for quantum information processing [6] with superconducting circuits [7] and also for other architectures [8].

In developing these qubit-resonator systems, one key ingredient is to design and realize transmission line resonators with high internal quality factor, Q_{int} , and with resonant frequency, ν_o , in the 5 – 15 GHz range to match the other energy scales of our device, and to be in the quantum regime ($h\nu_o \gg k_B T$) at $T = 30$ mK. On the other hand, the resonator is loaded with

input and output capacitances and we need a loaded quality factor $Q_L \approx 10^4$ in order to obtain reasonably fast rate of measurement, $\kappa = \nu_o/Q_L \approx 1$ MHz.

In fabricating the transmission line resonator, we opted for a coplanar waveguide (CPW) for many different reasons. First, a CPW has a simple layer structure with no need for deposited insulators. Second, it has a balanced structure with a relatively easy planar connection to the CPB. Third, a CPW has a ν_o that is relatively insensitive to kinetic inductance and dominated by geometrical distributed inductance. Last but not the least, CPW-based structures, made by Al thin film deposited on sapphire, have been recently shown [9] to allow very high Q 's (order of 10^6).

We decided to fabricate on passivated Si wafers because this is the substrate on which we had previously developed the qubit fabrication. We also decided to try as material for the resonators both Al, for easy compatibility with the qubit process, and Nb, because its higher critical temperature allows testing of resonators at higher temperatures.

In section II, we present design consideration for devices for circuit quantum electrodynamics (cQED). We will show that we can engineer Q with different coupling of the resonator to the input and output ports and that the internal losses can be made negligible at the designed Q [1]. Section III introduces the fabrication procedures for both the resonator and the CPB. Section IV-VI present an RF-characterization of the superconducting transmission line resonators versus temperature and magnetic field.

II. CIRCUIT DESIGN

A picture of a 10×3 mm² chip containing a 3 GHz superconducting Nb CPW resonator is shown in Fig. 1a. The length of the meandering resonator is $2l = 4$ mm. The center conductor is $10 \mu\text{m}$ wide, separated from the lateral ground planes extending to the edges of the chip by a $5 \mu\text{m}$ gap, resulting in a wave impedance of the coplanar waveguide of $Z = 50 \Omega$ to match the impedance of conventional microwave components. The capacitance per unit length is $C_s \approx 0.13$ fF/ μm^2 which gives a total resonator capacitance of $C = C_s l/2 = 1.6$ pF. The resonator is coupled by identical capacitors at each end (see solid line square in Fig. 1a) to an input and output feed line, fanning out to the edge of the chip and keeping the impedance constant. In Fig. 1b and 1d are shown micrographs of two of the coupling capacitors with different geometries. The one in Fig. 1b consists of two $100 \mu\text{m}$ long and $4 \mu\text{m}$ wide fingers separated by a $2 \mu\text{m}$ gap. It has a capacitance, $C_{\kappa,b} \approx 6$ fF, larger than that in

Manuscript received October 4, 2004. This work was supported in part by the National Security Agency (NSA) and Advanced Research and Development Activity (ARDA) under Army Research Office (ARO) contract number DAAD19-02-1-0045, the NSF ITR program under grant number DMR-0325580, the NSF under grant number DMR-0342157, the David and Lucile Packard Foundation, the W. M. Keck Foundation.

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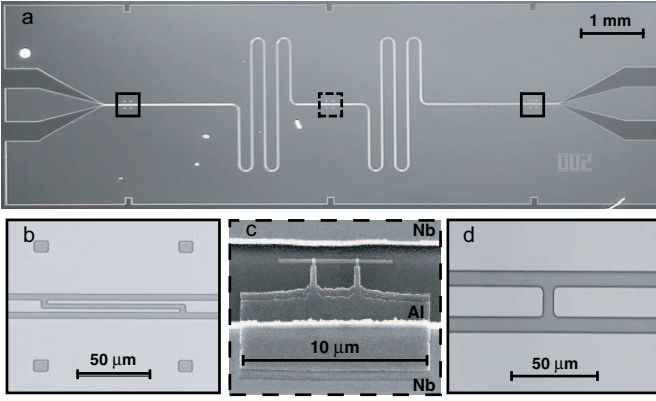


Fig. 1. Picture of a device for circuit QED. (a) The 3 GHz superconducting coplanar waveguide resonator is fabricated using optical lithography. The length of the meandering resonator is $l = 24$ mm. The center conductor is $10 \mu\text{m}$ wide, separated from the lateral ground planes extending to the edges of the chip by a $5 \mu\text{m}$ gap. The resonator is coupled by identical capacitors at each end (solid line squares) to input and output ports. (b) Micrograph of a coupling capacitance with two $100 \mu\text{m}$ long and $4 \mu\text{m}$ wide fingers separated by a $2 \mu\text{m}$ gap. (c) Scanning electron micrograph of a Cooper pair box fabricated onto the silicon substrate into the gap between the center conductor (top) and the ground plane (bottom) in the center of a resonator (dashed line square) using electron beam lithography and double angle evaporation of aluminium. (d) Micrograph of a coupling capacitance with a $4 \mu\text{m}$ gap.

Fig.1d, which has a simpler geometry with a $4 \mu\text{m}$ gap and $C_{\kappa,d} \approx 0.3 \text{ fF}$.

The capacitive coupling to the input and output lines, together with the loading impedance, $R_L = 50 \Omega$, are very important in determining the loaded quality factor Q_L , defined by the following equations:

$$\frac{1}{Q_L} = \frac{1}{Q_{int}} + \frac{1}{Q_{ext}} \quad (1)$$

where the external quality factor is

$$Q_{ext} = \frac{\omega C}{G_{ext}} \quad (2)$$

with

$$G_{ext} = \frac{2R_L C_{\kappa}^2 \omega^2}{1 + R_L^2 C_{\kappa}^2 \omega^2} \quad (3)$$

There are two possible regimes for the resonator. It can be undercoupled when C_{κ} is small (like $C_{\kappa,d}$) and then $Q_L \approx Q_{int}$. This is the regime in which it is possible to measure Q_{int} . Otherwise, the resonator can be overcoupled when C_{κ} is large (like $C_{\kappa,b}$) and then $Q_L \approx Q_{ext}$. It is then possible to engineer the Q_L to obtain fast measurement with κ much larger than the qubit decay rates [1].

In Fig. 1c an electron micrograph of a Cooper pair box is shown. The CPB consists of a $7 \mu\text{m}$ long and 200 nm wide superconducting island parallel to the center conductor which is coupled via two $200 \times 100 \text{ nm}^2$ size Josephson tunnel junctions to a much larger superconducting reservoir. The CPB is fabricated onto the silicon substrate (see dashed line square in Fig.1a) in the gap between the center conductor (top) and the ground plane (bottom) at an antinode of the electric field in the resonator. The Josephson junctions are formed at the overlap between the island and the fingers

extending from the reservoir, which is capacitively coupled to the ground plane. The CPB is a two-state system described by the hamiltonian $H = -(E_{el}\sigma_x + E_J\sigma_z)/2$ where E_{el} is the electrostatic energy and $E_J = E_{J,max} \cos(\pi\Phi_b)$ is the Josephson energy. The overall energy scales of these terms, the charging energy E_{el} and the Josephson energy $E_{J,max}$, can be readily engineered during the fabrication by the choice of the total box capacitance and resistance respectively, and then further tuned in situ by electrical means. A flux bias $\Phi_b = \Phi/\Phi_0$, applied with an external coil to the loop of the box, controls E_J . We have demonstrated that changing the length of the CPB island and its distance to the center conductor and changing the dielectrics (removing the passivation step of the Si substrate), we can obtain stronger couplings of qubit and resonator as predicted by simple electrostatic calculations of the capacitances.

III. DEVICE FABRICATION

The pattern of 36 different Nb resonators is generated exposing a bilayer photoresist (600 nm LOR5A and $1.2 \mu\text{m}$ S1813) through a mask with traditional UV photolithography. Then a 200 nm thick Nb film is dc magnetron sputtered in Ar at 1.5 Pa with a rate of 1 nm/s in an UHV system with a base pressure of $20 \mu\text{Pa}$. The substrate is a $2''$ $300 \mu\text{m}$ thick p-doped (Boron) (100) oriented Si wafer with resistivity $\rho > 1000 \Omega\text{cm}$ previously passivated by thermal wet oxidation with a 470 nm thick layer of SiO_2 . A lift-off process in NMP followed by ultrasonic agitation completes the resonator fabrication.

Al resonators are fabricated on the same type of substrate depositing a 200 nm thick Al film by thermal evaporation at a rate of 1 nm/s in the same UHV system. Then the same mask is used to expose a single photoresist layer ($1.2 \mu\text{m}$ S1813) and then realized by wet etching ($8 : 4 : 1 : 1 = \text{H}_3\text{PO}_4 : \text{CH}_3\text{COOH} : \text{HNO}_3 : \text{H}_2\text{O}$) the metal.

In both cases, chips containing individual resonators are obtained by dicing the Si wafer. The CPB qubit (Fig. 1c) is then fabricated on an individual resonator by a simple Dolan bridge technique [10] exposing a bilayer resist (500 nm MMA-(8.5)MAA EL13 and 100 nm 950K PMMA A3) by e-beam lithography and then e-beam evaporating Al (35 nm for the base and 70 nm for the top electrode) at a rate of 1 nm/s in a double-angle UHV system with a base pressure of $20 \mu\text{Pa}$. The junction barrier is realized with a 12 min thermal oxidation in a 400 Pa of O_2 . A lift-off process in hot acetone and ultrasonic agitation complete the device. To couple the qubit reservoir to ground with a large capacitance, the base electrode is deposited with a little angle taking advantage of the shadow of the thicker Nb film to define the capacitor.

IV. MEASUREMENT TECHNIQUE

The frequency dependence of the transmission through the resonators [11] was measured using a vector network analyzer. The equivalent circuit of the measurement setup is shown in the inset of Fig. 3. The sample was mounted on a PC board in a closed copper sample box (Fig. 2) equipped with blind mate SMP connectors that launch the microwaves onto the PC

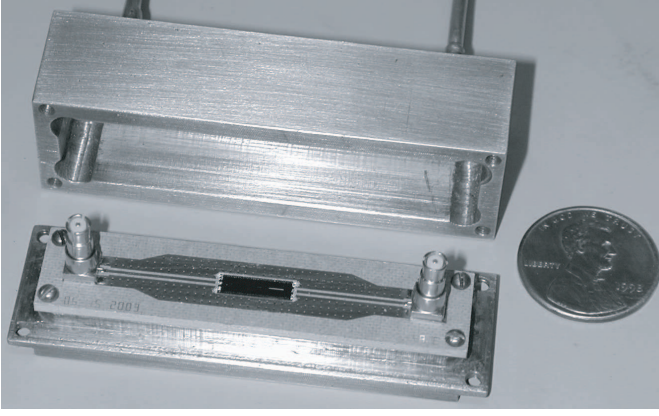


Fig. 2. Picture of the copper sample box containing a resonator mounted on the PC board.

board CPW's. The sample was cooled to temperatures ranging from the critical temperature, T_c of the superconducting films down to $T = 30$ mK.

The transmission S_{21} through the resonator around its fundamental resonant frequency ν_o is shown in Fig. 3 at $T = 30$ mK. The curve was acquired using a -60 dBm input power [12] and a room temperature amplifier. The input power was lowered until no distortion of the resonance curve due to excessive input power could be observed. The network analyzer was response calibrated (S_{21}) up to the input and output ports of the cryostat and the absorption of the cabling in the cryostat was determined to be approximately -7 dB in a calibrated S_{11} and S_{22} reflection measurement. The quality factor of the resonator is determined by fitting a Lorentzian line to the measured power spectrum as shown by the solid line in Fig. 3. This is the power spectrum of an undercoupled resonator and from the fit we have extracted $\nu_o = 3.03694$ GHz. At this frequency the insertion loss is $L_o = -13$ dB. The quality factor is determined from the full width at half max of the fitted power spectrum and is found to be $Q_L \approx Q_{int} = \nu_o / 2\delta\nu_o = 2\pi\nu_o / \kappa = 0.55 \times 10^6$.

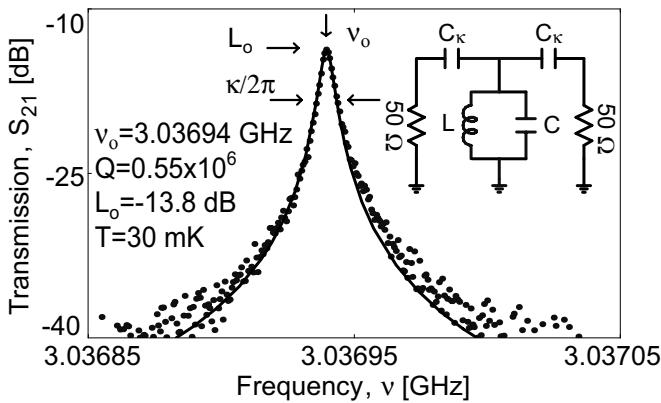


Fig. 3. Measured transmission power spectrum of an undercoupled resonator. The solid line is a fit to a Lorentzian line.

V. TEMPERATURE DEPENDENCE OF Q AND ν_o

In Fig. 4, we show the measured temperature dependence of the quality factor Q for an undercoupled resonator (solid dots)

and an overcoupled one (open dots). The lines in Fig. 4 are generated by summing a Q_{int} that scales exponentially with the reduced temperature, T_c/T , in parallel with a constant Q_{ext} . At low temperature, the coupling saturates the Q of the overcoupled resonator, while it seems that Q for the undercoupled one has still some weak temperature dependence whose nature is still unknown. We speculate that either vortices or losses in the dielectrics could limit the Q of this resonator but neither of these interpretations offer an easy understanding of the weak temperature dependence.

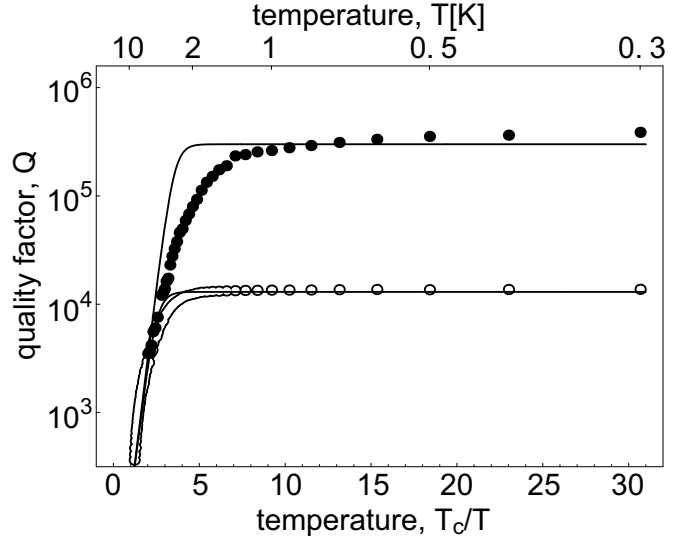


Fig. 4. Temperature dependence of the quality factor Q of two 3 GHz superconducting Nb coplanar waveguide resonators at their first harmonic resonant frequency (6 GHz). Solid dots are data collected on an undercoupled resonator and open dots are from an overcoupled one. The lines are generated by summing a Q_{int} that scales exponentially with the reduced temperature, T_c/T , in parallel with a constant Q_{ext} .

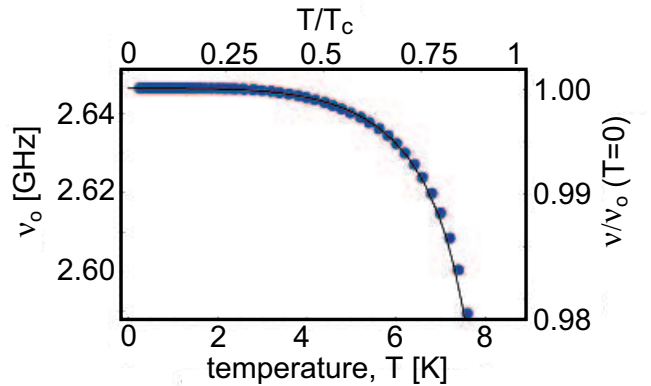


Fig. 5. Temperature dependence of the resonant frequency ν_o of a superconducting Nb coplanar waveguide resonator. Solid line is a fit to a kinetic inductance model.

We have observed a shift of the resonant frequency ν_o with temperature as shown in Fig. 5, which can be understood in terms of the temperature dependent kinetic inductance of the resonator [9], [13]. ν_o is proportional to $1/\sqrt{L}$, where the total inductance of the resonator L is the sum of the temperature

independent geometric inductance L_m and the temperature dependent kinetic inductance L_k . The kinetic inductance scales as $L_k \propto \lambda_L(T)^2$, where $\lambda_L(T)$ is the temperature dependent London penetration depth. The best fit in Fig. 4 was achieved for a ratio $L_k/L_m \approx 4\%$ and a critical temperature of $T_c \approx 8.75$ K, which we have independently measured on a test sample fabricated on the same wafer.

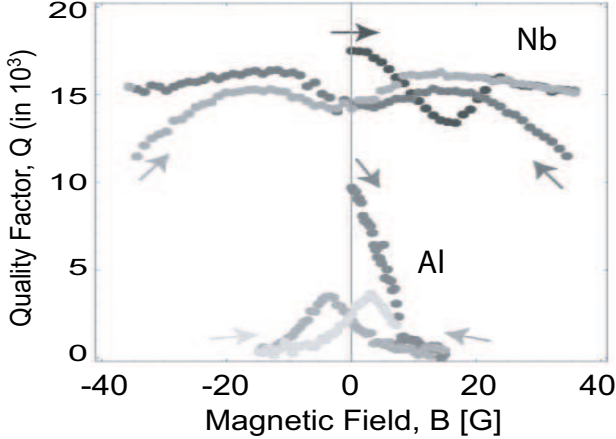


Fig. 6. Magnetic field dependence of the quality factor Q of two different superconducting coplanar waveguide resonators at $T = 300$ mK. In the upper part data refer to a Nb resonator, while in the lower part they refer to an Al resonator. Arrows indicate the direction in which the magnetic field was swept in both case starting from zero.

VI. MAGNETIC FIELD DEPENDENCE OF Q

As explained in section II, we need to apply a magnetic field perpendicular to the qubit loop in order to tune E_J . Then, we measured the quality factor of two resonators as a function of the magnetic field at $T = 300$ mK, as shown in Fig. 6. It is evident that the Nb film (upper part) is less sensitive to the applied field than the Al film (lower part). In both cases there seems to be a reproducible and irreversible hysteretic behavior that can be reset by thermal cycling the sample. In our recent works [1], we have observed a focusing effect on the magnetic field such that the effective field in the gap of the resonator was approximately two orders of magnitude larger than the applied magnetic field. We believe that the hysteretic phenomena could be in fact a result of vortices being trapped in the resonator film due to these large effective fields.

VII. CONCLUSION

In summary, we have designed and fabricated devices for realizing a circuit quantum electrodynamics architecture in which a qubit can be strongly coupled to a single microwave photon. We have shown that we can engineer Q with different coupling of the resonator to the input and output ports and that the internal losses can be made negligible at the designed Q . Indeed, we have achieved high $Q = 0.55 \times 10^6$ in the undercoupled CPW resonators and $Q \approx 10^4$ in the overcoupled ones, which allow fast measurement of the qubit.

To help determine the mechanism of the losses, one can fabricate resonators on different substrates (Si with different

resistivity, sapphire, Si_3N_4), or in different superconductors (Ta, Al). In fact, quality factor measurements in this type of resonant circuits serve as a sensitive probe of material losses in dielectrics and superconductors in the GHz frequency range at millikelvin temperatures. These presently unknown properties may in fact pose a serious limit for all superconducting qubits, though the large internal Q 's already observed are highly encouraging. Better knowledge of the material losses, and techniques to characterize them, may be crucial not only for future improvements of circuit QED devices, but also for designing and realizing robust, long-lived superconducting qubits.

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